# NTD4804N, NVD4804N

# MOSFET – Power, Single, N-Channel, DPAK/IPAK
## 30 V, 117 A

### Features
- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC Q101 Qualified – NVD4804N
- These Devices are Pb–Free and are RoHS Compliant

### Applications
- CPU Power Delivery
- DC–DC Converters
- Low Side Switching

**MAXIMUM RATINGS** ($T_J$ = 25°C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|---|---|---|---|---|---|
| Drain–to–Source Voltage | | | $V_{DSS}$ | 30 | V |
| Gate–to–Source Voltage | | | $V_{GS}$ | ±20 | V |
| Continuous Drain Current ($R_{\theta JA}$) (Note 1) | Steady State | $T_A$ = 25°C | $I_D$ | 19.6 | A |
| | | $T_A$ = 85°C | | 15.2 | |
| Power Dissipation ($R_{\theta JA}$) (Note 1) | | $T_A$ = 25°C | $P_D$ | 2.66 | W |
| Continuous Drain Current ($R_{\theta JA}$) (Note 2) | | $T_A$ = 25°C | $I_D$ | 14.5 | A |
| | | $T_A$ = 85°C | | 11 | |
| Power Dissipation ($R_{\theta JA}$) (Note 2) | | $T_A$ = 25°C | $P_D$ | 1.43 | W |
| Continuous Drain Current ($R_{\theta JC}$) (Note 1) | | $T_C$ = 25°C | $I_D$ | 124 | A |
| | | $T_C$ = 85°C | | 96 | |
| Power Dissipation ($R_{\theta JC}$) (Note 1) | | $T_C$ = 25°C | $P_D$ | 107 | W |
| Pulsed Drain Current | $t_p$=10μs | $T_A$ = 25°C | $I_{DM}$ | 230 | A |
| Current Limited by Package | | $T_A$ = 25°C | $I_{DmaxPkg}$ | 45 | A |
| Operating Junction and Storage Temperature | | | $T_J$, $T_{stg}$ | –55 to 175 | °C |
| Source Current (Body Diode) | | | $I_S$ | 78 | A |
| Drain to Source dV/dt | | | dV/dt | 6.0 | V/ns |
| Single Pulse Drain–to–Source Avalanche Energy ($V_{DD}$ = 24 V, $V_{GS}$ = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 30 A, $R_G$ = 25 Ω) | | | $E_{AS}$ | 450 | mJ |
| Lead Temperature for Soldering Purposes (1/8″ from case for 10 s) | | | $T_L$ | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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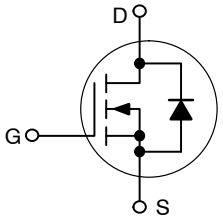
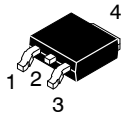
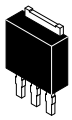
| $V_{(BR)DSS}$ | $R_{DS(on)}$ MAX | $I_D$ MAX |
|---|---|---|
| 30 V | 4.0 mΩ @ 10 V | 117 A |
| | 5.5 mΩ @ 4.5 V | |

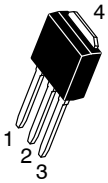


N–Channel



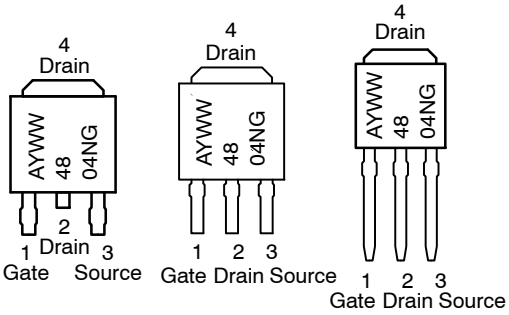
**CASE 369AA DPAK (Bent Lead) STYLE 2**


**CASE 369AD 3 IPAK (Straight Lead)**



**CASE 369D IPAK (Straight Lead DPAK)**

### MARKING DIAGRAMS & PIN ASSIGNMENTS




A = Assembly Location
Y = Year
WW = Work Week
4804N = Device Code
G = Pb–Free Package

### ORDERING INFORMATION
See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

## THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|---|---|---|
| Junction−to−Case (Drain) | $R_{\theta JC}$ | 1.4 | °C/W |
| Junction−to−TAB (Drain) | $R_{\theta JC-TAB}$ | 3.5 | |
| Junction−to−Ambient − Steady State (Note 1) | $R_{\theta JA}$ | 56.4 | |
| Junction−to−Ambient − Steady State (Note 2) | $R_{\theta JA}$ | 105 | |

1. Surface−mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
2. Surface−mounted on FR4 board using the minimum recommended pad size.

## ELECTRICAL CHARACTERISTICS ($T_J$ = 25°C unless otherwise noted)

| Parameter | Symbol | Test Condition | | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|---|
| **OFF CHARACTERISTICS** | | | | | | | |
| Drain−to−Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS}$ = 0 V, $I_D$ = 250 μA | | 30 | | | V |
| Drain−to−Source Breakdown Voltage Temperature Coefficient | $V_{(BR)DSS}/T_J$ | | | | 26 | | mV/°C |
| Zero Gate Voltage Drain Current | $I_{DSS}$ | $V_{GS}$ = 0 V, $V_{DS}$ = 24 V | $T_J$ = 25°C | | | 1.0 | μA |
| | | | $T_J$ = 125°C | | | 10 | |
| Gate−to−Source Leakage Current | $I_{GSS}$ | $V_{DS}$ = 0 V, $V_{GS}$ = ±20 V | | | | ±100 | nA |
| **ON CHARACTERISTICS** (Note 3) | | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS}$ = $V_{DS}$, $I_D$ = 250 μA | | 1.5 | | 2.5 | V |
| Negative Threshold Temperature Coefficient | $V_{GS(TH)}/T_J$ | | | | 7.6 | | mV/°C |
| Drain−to−Source On Resistance | $R_{DS(on)}$ | $V_{GS}$ = 10 to 11.5 V | $I_D$ = 30 A | | 3.4 | 4.0 | mΩ |
| | | | $I_D$ = 15 A | | 3.4 | | |
| | | $V_{GS}$ = 4.5 V | $I_D$ = 30 A | | 4.7 | 5.5 | |
| | | | $I_D$ = 15 A | | 4.6 | | |
| Forward Transconductance | gFS | $V_{DS}$ = 15 V, $I_D$ = 15 A | | | 23 | | S |
| **CHARGES AND CAPACITANCES** | | | | | | | |
| Input Capacitance | $C_{iss}$ | $V_{GS}$ = 0 V, f = 1.0 MHz, $V_{DS}$ = 12 V | | | 4490 | | pF |
| Output Capacitance | $C_{oss}$ | | | | 952 | | |
| Reverse Transfer Capacitance | $C_{rss}$ | | | | 556 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_D$ = 30 A | | | 30 | 40 | nC |
| Threshold Gate Charge | $Q_{G(TH)}$ | | | | 5.5 | | |
| Gate−to−Source Charge | $Q_{GS}$ | | | | 13 | | |
| Gate−to−Drain Charge | $Q_{GD}$ | | | | 13 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_D$ = 30 A | | | 73 | | nC |
| **SWITCHING CHARACTERISTICS** (Note 4) | | | | | | | |
| Turn−On Delay Time | $t_{d(on)}$ | $V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_D$ = 15 A, $R_G$ = 3.0 Ω | | | 18 | | ns |
| Rise Time | $t_r$ | | | | 20 | | |
| Turn−Off Delay Time | $t_{d(off)}$ | | | | 24 | | |
| Fall Time | $t_f$ | | | | 8 | | |
| Turn−On Delay Time | $t_{d(on)}$ | $V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_D$ = 15 A, $R_G$ = 3.0 Ω | | | 10 | | ns |
| Rise Time | $t_r$ | | | | 19 | | |
| Turn−Off Delay Time | $t_{d(off)}$ | | | | 35 | | |
| Fall Time | $t_f$ | | | | 5 | | |

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

**ELECTRICAL CHARACTERISTICS** ($T_J$ = 25°C unless otherwise noted)

| Parameter | Symbol | Test Condition | | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|---|
| **DRAIN−SOURCE DIODE CHARACTERISTICS** | | | | | | | |
| Forward Diode Voltage | $V_{SD}$ | $V_{GS}$ = 0 V, $I_S$ = 30 A | $T_J$ = 25°C | | 0.81 | 1.2 | V |
| | | | $T_J$ = 125°C | | 0.72 | | |
| Reverse Recovery Time | $t_{RR}$ | $V_{GS}$ = 0 V, dIs/dt = 100 A/μs, $I_S$ = 30 A | | | 34 | | ns |
| Charge Time | ta | | | | 19 | | |
| Discharge Time | tb | | | | 15 | | |
| Reverse Recovery Time | $Q_{RR}$ | | | | 30 | | nC |
| **PACKAGE PARASITIC VALUES** | | | | | | | |
| Source Inductance | $L_S$ | $T_A$ = 25°C | | | 2.49 | | nH |
| Drain Inductance, DPAK | $L_D$ | | | | 0.0164 | | |
| Drain Inductance, IPAK | $L_D$ | | | | 1.88 | | |
| Gate Inductance | $L_G$ | | | | 3.46 | | |
| Gate Resistance | $R_G$ | | | | 0.6 | | Ω |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## TYPICAL PERFORMANCE CURVES

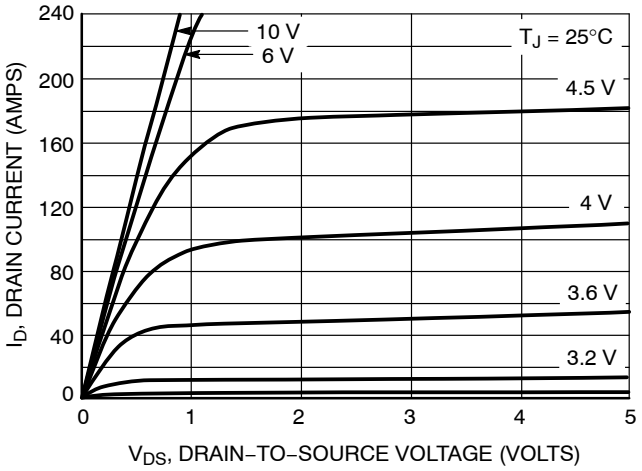



**Figure 1. On−Region Characteristics**

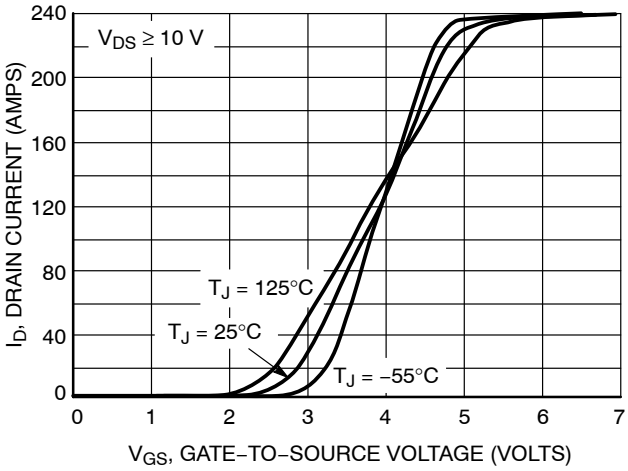



**Figure 2. Transfer Characteristics**

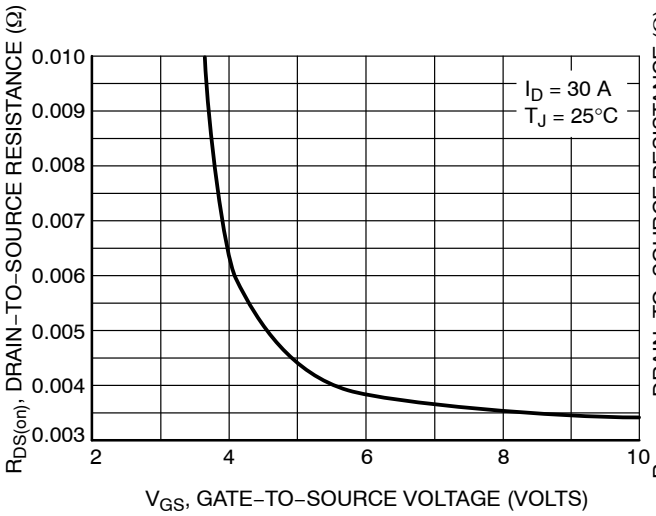



**Figure 3. On−Resistance vs. Gate−to−Source Voltage**

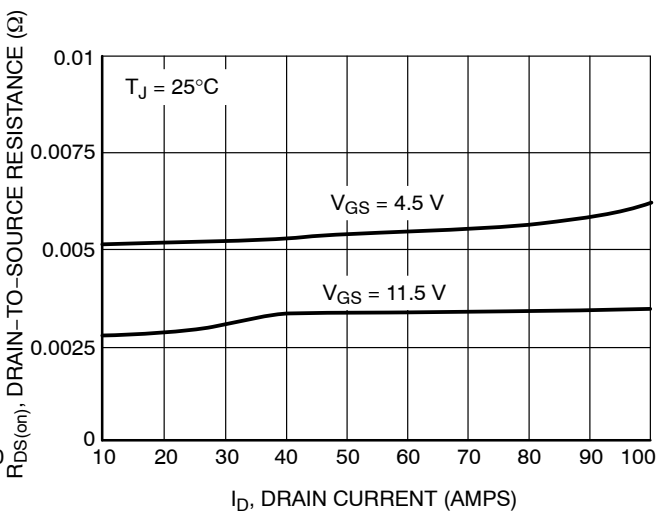



**Figure 4. On−Resistance vs. Drain Current and Gate Voltage**

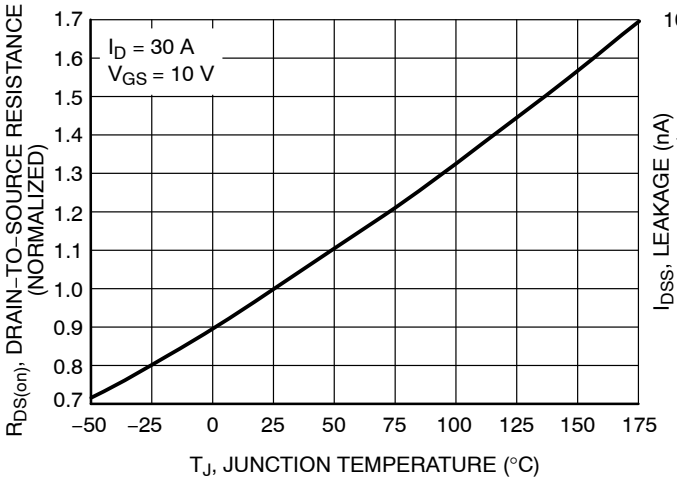



**Figure 5. On−Resistance Variation with Temperature**

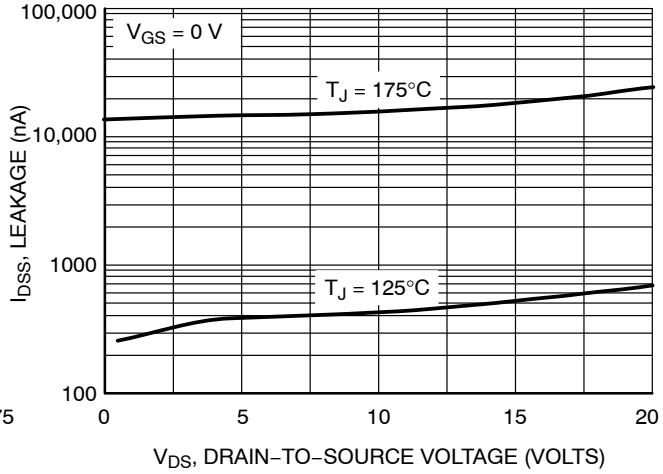



**Figure 6. Drain−to−Source Leakage Current vs. Drain Voltage**

## TYPICAL PERFORMANCE CURVES

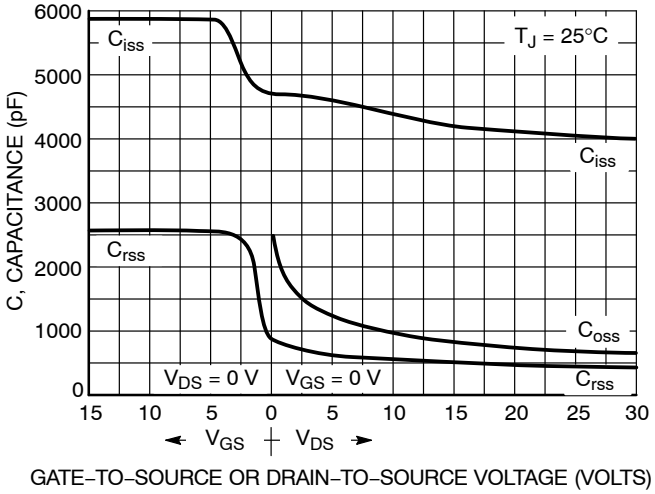



**Figure 7. Capacitance Variation**

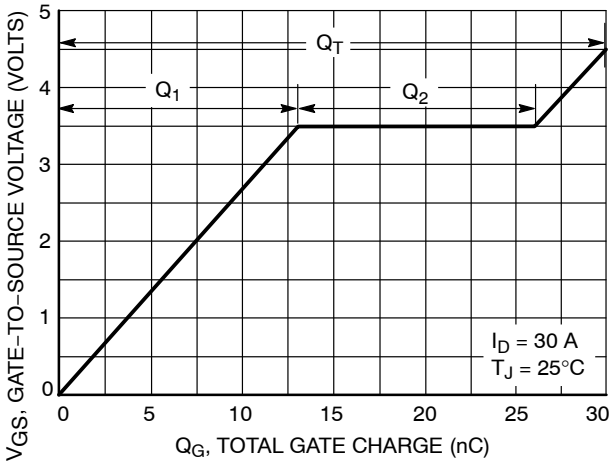



**Figure 8. Gate–To–Source and Drain–To–Source Voltage vs. Total Charge**

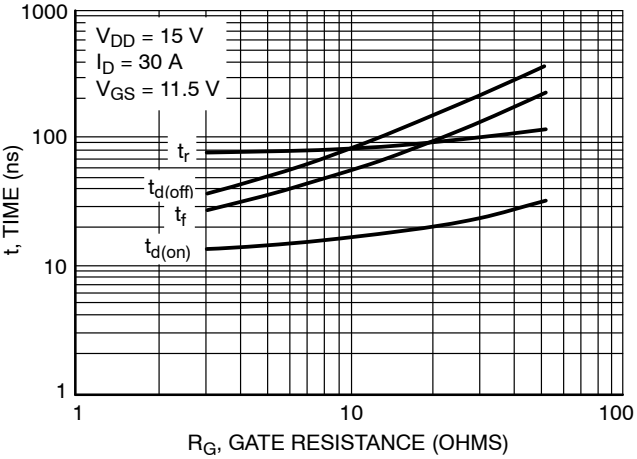



**Figure 9. Resistive Switching Time Variation vs. Gate Resistance**

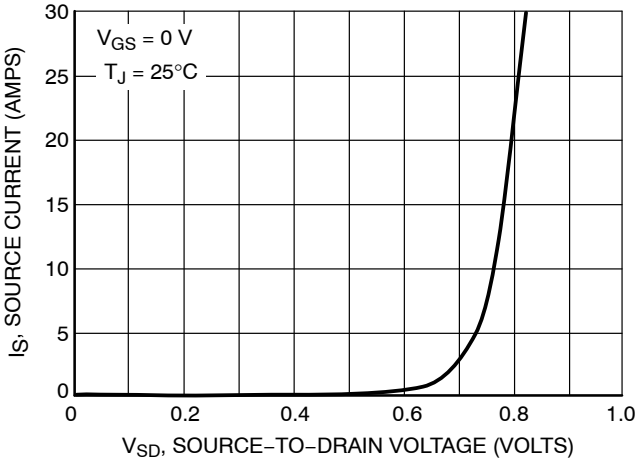



**Figure 10. Diode Forward Voltage vs. Current**

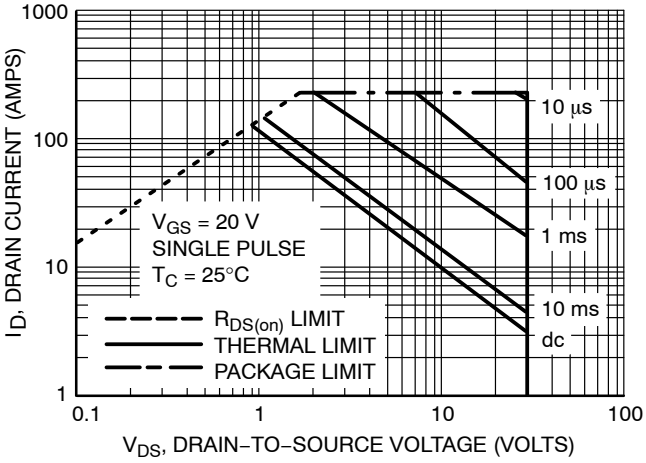



**Figure 11. Maximum Rated Forward Biased Safe Operating Area**

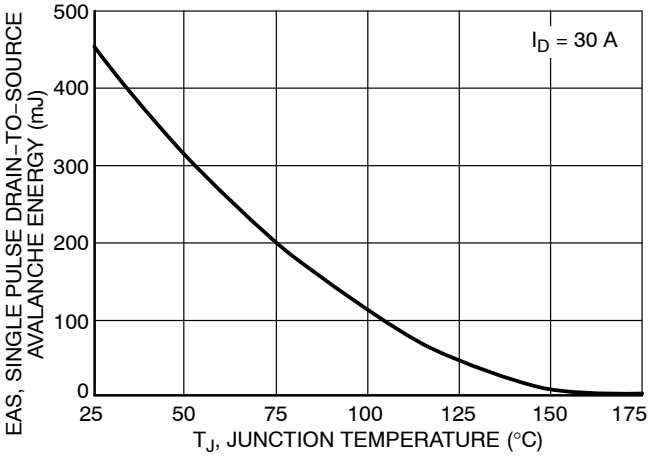



**Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature**

## TYPICAL PERFORMANCE CURVES

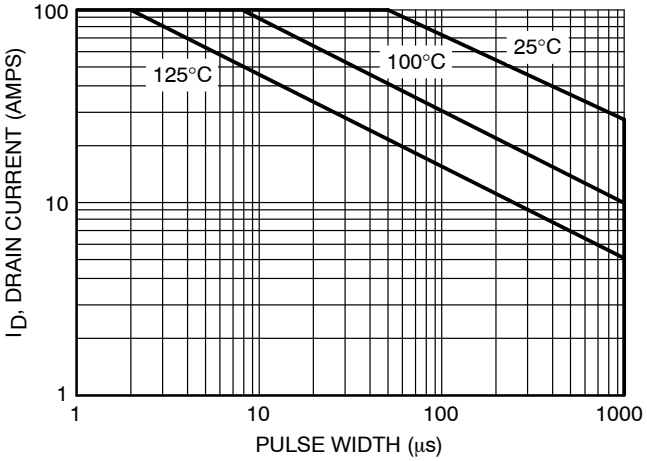



**Figure 13. Avalanche Characteristics**

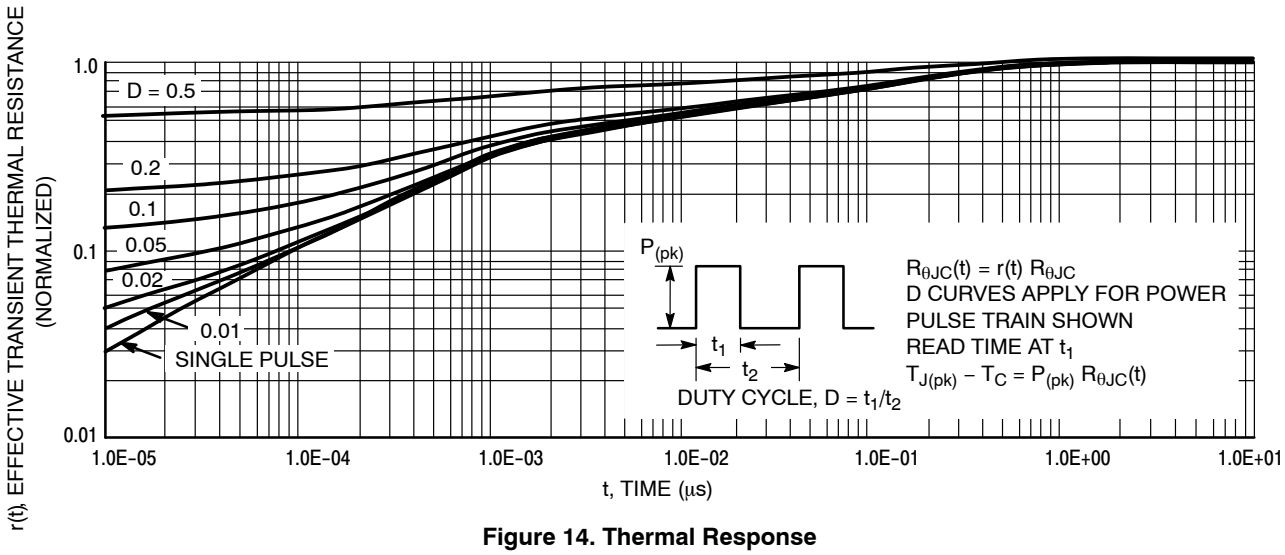



**Figure 14. Thermal Response**

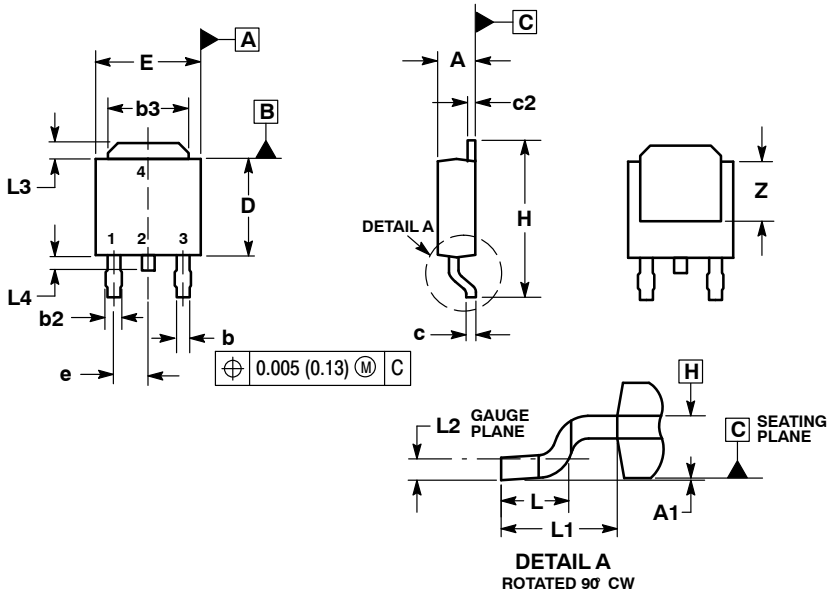
### ORDERING INFORMATION

| Order Number | Package | Shipping† |
|---|---|---|
| NTD4804NT4G | DPAK (Pb−Free) | 2500 / Tape & Reel |
| NTD4804N−35G | IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb−Free) | 75 Units / Rail |
| NVD4804NT4G | DPAK (Pb−Free) | 2500 / Tape & Reel |
| NVD4804NT4G−VF01 | DPAK (Pb−Free) | 2500 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

### DPAK (SINGLE GUAGE)
CASE 369AA
ISSUE B

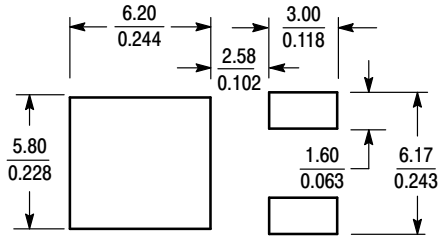



NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: INCHES.
3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

| | INCHES | | MILLIMETERS | |
|---|---|---|---|---|
| DIM | MIN | MAX | MIN | MAX |
| A | 0.086 | 0.094 | 2.18 | 2.38 |
| A1 | 0.000 | 0.005 | 0.00 | 0.13 |
| b | 0.025 | 0.035 | 0.63 | 0.89 |
| b2 | 0.030 | 0.045 | 0.76 | 1.14 |
| b3 | 0.180 | 0.215 | 4.57 | 5.46 |
| c | 0.018 | 0.024 | 0.46 | 0.61 |
| c2 | 0.018 | 0.024 | 0.46 | 0.61 |
| D | 0.235 | 0.245 | 5.97 | 6.22 |
| E | 0.250 | 0.265 | 6.35 | 6.73 |
| e | 0.090 BSC | | 2.29 BSC | |
| H | 0.370 | 0.410 | 9.40 | 10.41 |
| L | 0.055 | 0.070 | 1.40 | 1.78 |
| L1 | 0.108 REF | | 2.74 REF | |
| L2 | 0.020 BSC | | 0.51 BSC | |
| L3 | 0.035 | 0.050 | 0.89 | 1.27 |
| L4 | --- | 0.040 | --- | 1.01 |
| Z | 0.155 | --- | 3.93 | --- |

STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

### SOLDERING FOOTPRINT*

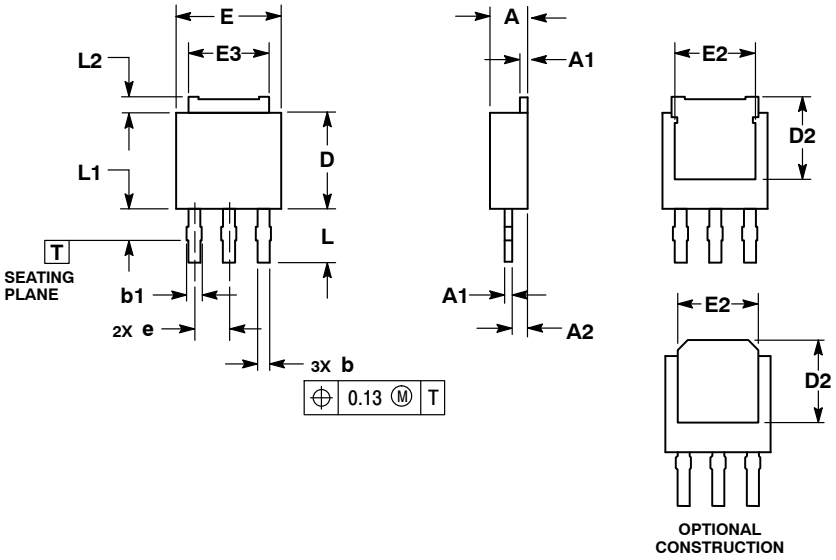



SCALE 3:1 (mm / inches)

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## PACKAGE DIMENSIONS

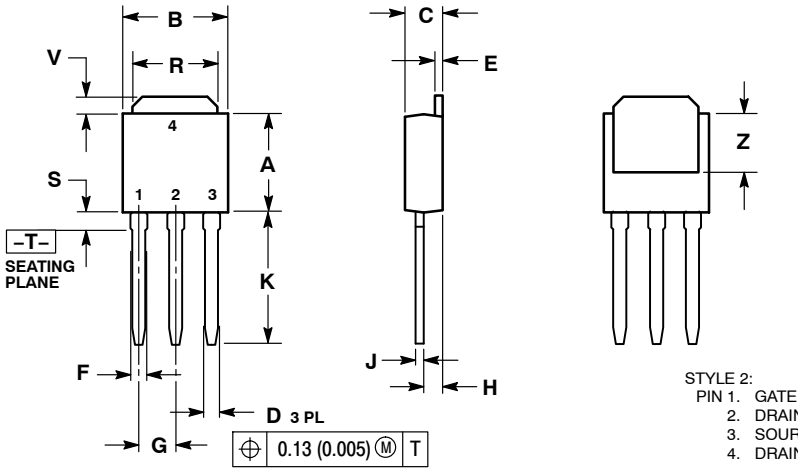
### 3.5 MM IPAK, STRAIGHT LEAD
CASE 369AD
ISSUE B




NOTES:
1.. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2.. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

| | MILLIMETERS | |
|---|---|---|
| DIM | MIN | MAX |
| A | 2.19 | 2.38 |
| A1 | 0.46 | 0.60 |
| A2 | 0.87 | 1.10 |
| b | 0.69 | 0.89 |
| b1 | 0.77 | 1.10 |
| D | 5.97 | 6.22 |
| D2 | 4.80 | --- |
| E | 6.35 | 6.73 |
| E2 | 4.57 | 5.45 |
| E3 | 4.45 | 5.46 |
| e | 2.28 BSC | |
| L | 3.40 | 3.60 |
| L1 | --- | 2.10 |
| L2 | 0.89 | 1.27 |

### IPAK
CASE 369D
ISSUE C




NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

| | INCHES | | MILLIMETERS | |
|---|---|---|---|---|
| DIM | MIN | MAX | MIN | MAX |
| A | 0.235 | 0.245 | 5.97 | 6.35 |
| B | 0.250 | 0.265 | 6.35 | 6.73 |
| C | 0.086 | 0.094 | 2.19 | 2.38 |
| D | 0.027 | 0.035 | 0.69 | 0.88 |
| E | 0.018 | 0.023 | 0.46 | 0.58 |
| F | 0.037 | 0.045 | 0.94 | 1.14 |
| G | 0.090 BSC | | 2.29 BSC | |
| H | 0.034 | 0.040 | 0.87 | 1.01 |
| J | 0.018 | 0.023 | 0.46 | 0.58 |
| K | 0.350 | 0.380 | 8.89 | 9.65 |
| R | 0.180 | 0.215 | 4.45 | 5.45 |
| S | 0.025 | 0.040 | 0.63 | 1.01 |
| V | 0.035 | 0.050 | 0.89 | 1.27 |
| Z | 0.155 | --- | 3.93 | --- |



## PUBLICATION ORDERING INFORMATION

**LITERATURE FULFILLMENT**:
Literature Distribution Center for ON Semiconductor
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**Email**: orderlit@onsemi.com

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**Europe, Middle East and Africa Technical Support:**
Phone: 421 33 790 2910
**Japan Customer Focus Center**
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